## Notice of References Cited Application/Control No. 10/624,224 Examiner Andrew Schechter U.S. PATENT DOCUMENTS \* Document Number Country Code-Number-Kind Code MM-YYYY Name Applicant(s)/Patent Under Reexamination TANAKA ET AL. Examiner Andrew Schechter U.S. PATENT DOCUMENTS \* Document Number Country Code-Number-Kind Code MM-YYYY Name Classification A US-6,204,081 B US-

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,204,081	03-2001	Kim et al.	438/30
	В	US-			
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
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	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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## **NON-PATENT DOCUMENTS**

*	ļ	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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**Notice of References Cited** 

Part of Paper No. 20050727